INTEGRATED CIRCUITS



Product specification IC05 Data Handbook 1991 Feb 08



Philips Semiconductors

74ALS174

FEATURES

- Four edge-triggered D flip-flops
- Buffered common clock
- Buffered asynchronous master reset

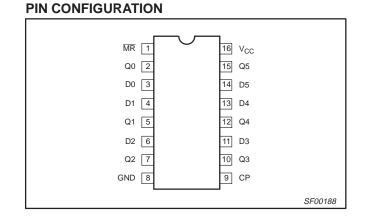
DESCRIPTION

The 74ALS174 has six edge-triggered D-type flip-flops with individual D inputs and Q outputs. The common buffered clock (CP) and master reset ($\overline{\text{MR}}$) inputs load and reset (clear) all flip-flops simultaneously.

The register is fully edge-triggered. The state of each D input, one setup time before the Low-to-High clock transition is transferred to the corresponding flip-flop's Q output.

All Q outputs will be forced Low independent of clock or data inputs by a Low voltage level on the $\overline{\text{MR}}$ input. The device is useful for applications where true outputs only are required, and the clock and master reset are common to all storage elements.

TYPE	TYPICAL f _{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS174	70MHz	7mA



ORDERING INFORMATION

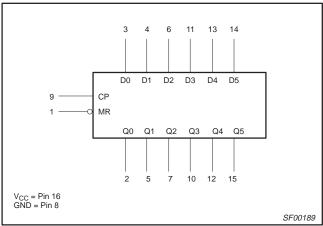
	ORDER CODE	
DESCRIPTION	COMMERCIAL RANGE V_{CC} = 5V ±10%, T_{amb} = 0°C to +70°C	DRAWING NUMBER
16-pin plastic DIP	74ALS174N	SOT38-4
16-pin plastic SO	74ALS174D	SOT109-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

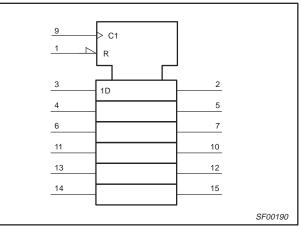
PINS	DESCRIPTION	74ALS (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D0 – D3	Data inputs	1.0/1.0	20µA/0.1mA
CP	Clock Pulse input (active rising edge)	1.0/1.0	20µA/0.1mA
MR	Master Reset input (active-Low)	1.0/1.0	20µA/0.1mA
Q0 – Q5	Data outputs	20/80	0.4mA/8mA

NOTE: One (1.0) ALS unit load is defined as: 20µA in the High state and 0.1mA in the Low state.

LOGIC SYMBOL

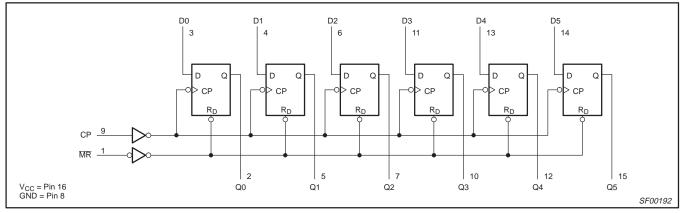


IEC/IEEE SYMBOL



74ALS174

LOGIC DIAGRAM



FUNCTION TABLE

	INPUTS		OUTPUTS	OPERATING
MR	СР	D	Q _n	MODE
L	Х	Х	L	Reset (clear)
Н	\uparrow	h	Н	Load "1"
Н	\uparrow	I	L	Load "0"

NOTES:

H = High-voltage level

h = High state must be present one setup time before the Low-to-High clock transition

L = Low-voltage level

I = Low state must be present one setup time before the Low-to-High clock transition

X = Don't care $\uparrow = Low-to-Hig$

↑ = Low-to-High clock transition

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	–0.5 to V _{CC}	V
I _{OUT}	Current applied to output in Low output state	16	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		UNIT		
STMBOL	FARAMETER	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{IK}	Input clamp current			-18	mA
I _{ОН}	High-level output current			-0.4	mA
I _{OL}	Low-level output current			8	mA
T _{amb}	Operating free-air temperature range	0		+70	°C

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

CYMDOL	DADAMETED	TEST CONDIT				LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS ¹		MIN	TYP ²	MAX	UNIT		
V _{OH}	High-level output voltage	$V_{CC}\pm 10\%$, $V_{IL} = MAX$, V_{IH}	= MIN, I _{OH} = MAX	V _{CC} – 2			V		
M		$V_{CC} = MIN, V_{IL} = MAX,$	$I_{OL} = 4mA$		0.25	0.4	V		
V _{OL} Lo	Low-level output voltage	V _{IH} = MIN	$I_{OL} = 8mA$		0.35	0.50	V		
V _{IK}	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.5	V		
I _I	Input current at maximum input voltage	$V_{CC} = MAX, V_I = 7.0V$				100	μA		
I _{IH}	High-level input current	$V_{CC} = MAX, V_I = 2.7V$				20	μΑ		
I _{IL}	Low-level input current	$V_{CC} = MAX, V_I = 0.5V$	$V_{CC} = MAX, V_I = 0.5V$			-0.1	mA		
Ι _Ο	Output current ³	$V_{CC} = MAX, V_O = 2.25V$		-30		-112	mA		
I _{CC}	Supply current (total)	V _{CC} = MAX			7	14	mA		

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

AC ELECTRICAL CHARACTERISTICS

			LIM		
SYMBOL	PARAMETER	TEST CONDITION	T _{amb} = 0°C V _{CC} = +5. C _L = 50pF,	UNIT	
			MIN	MAX	
f _{MAX}	Maximum clock frequency	Waveform 1	60		MHz
t _{PLH} t _{PHL}	Propagation delay CP to Qn	Waveform 1	5.0 5.0	15.0 15.0	ns
t _{PHL}	Propagation delay, \overline{MR} to Qn	Waveform 2	8.0	18.0	ns

AC SETUP REQUIREMENTS

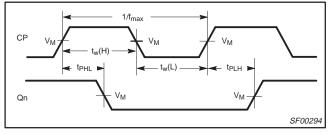
			LIM		
SYMBOL	PARAMETER	TEST CONDITION	T _{amb} = 0°0 V _{CC} = +5. C _L = 50pF,	C to +70°C 0V ± 10% R _L = 500Ω	UNIT
			MIN	MAX	
t _{su} (H) t _{su} (L)	Setup time, High or Low Dn to CP	Waveform 3	6.0 6.0		ns
t _h (H) t _h (L)	Hold time, High or Low Dn to CP	Waveform 3	0.0 0.0		ns
t _w (H) t _w (L)	CP pulse width, High or Low	Waveform 1	8.0 8.0		ns
t _w (L)	MR pulse width, Low	Waveform 2	6.0		ns
t _{REC}	Recovery time, MR to CP	Waveform 2	6.0		ns

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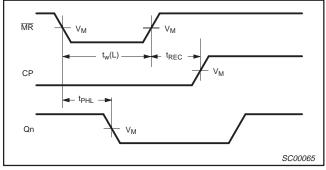
AC WAVEFORMS

For all waveforms, $V_M = 1.3V$.

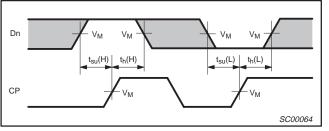
The shaded areas indicate when the input is permitted to change for predictable output performance.



Waveform 1. Propagation Delay for Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency

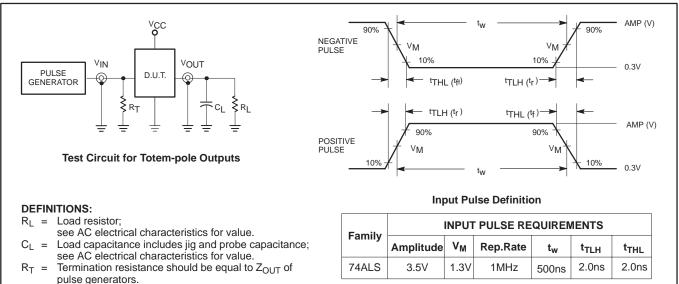


Waveform 2. Master Reset Pulse Width, Master Reset to Output Delay, and Master Reset to Clock Recovery Time

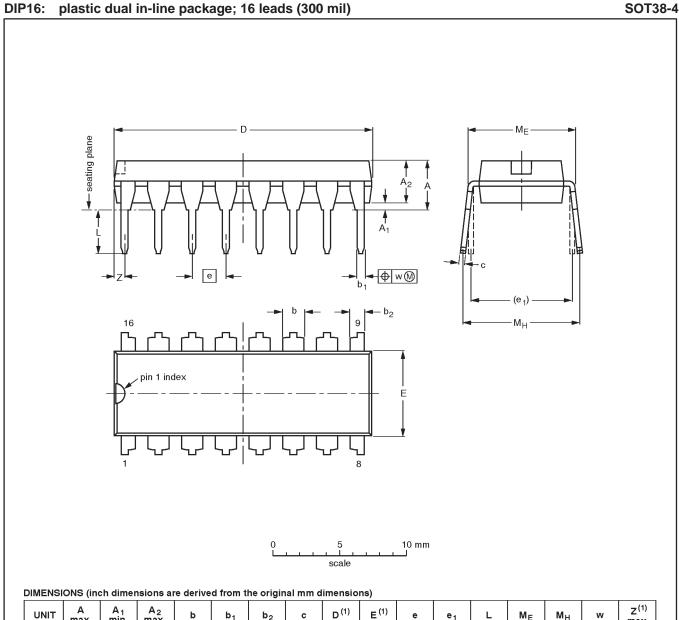


Waveform 3. Data Setup and Hold Times

TEST CIRCUIT AND WAVEFORMS



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UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	с	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

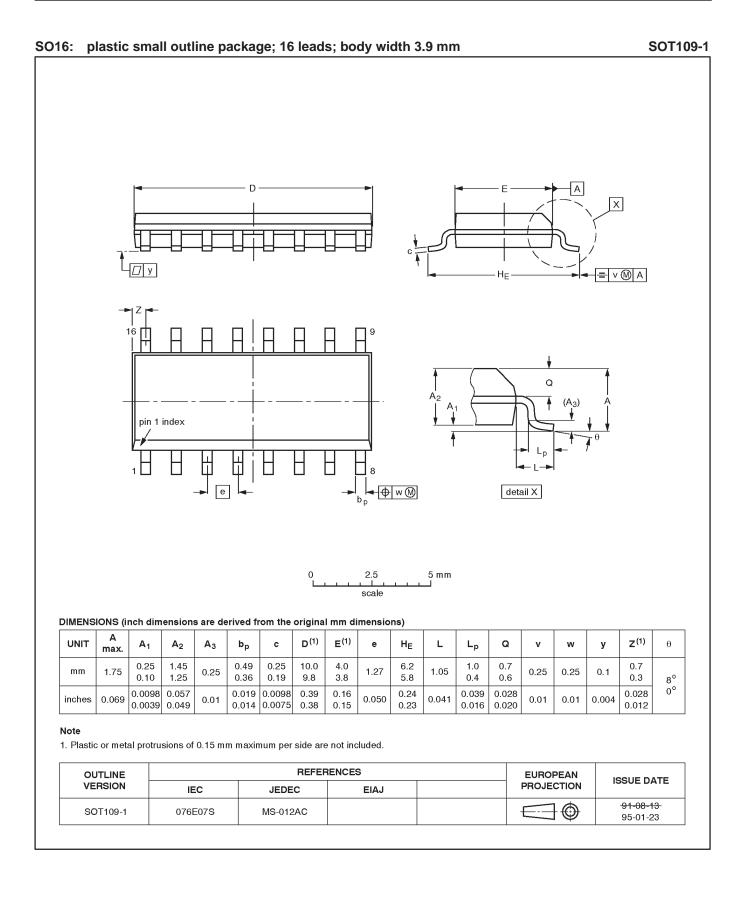
OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC JEDEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT38-4						-92-11-17 95-01-14

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Product specification

Product specification

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74ALS174
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74ALS174

DEFINITIONS								
Data Sheet Identification	Product Status	Definition						
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.						
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.						
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